

NEW! QNix® 8500: Magnetic-Inductive Measurement Probe MI Fe 500 μm Extension of our modular measurement system QNix® 8500: A pen shaped probe for precise measurements of particularly thin coatings and smallest parts.

In addition to our standard probes, operating based on the Hall-sensor principle, a magnetic-inductive measurement probe for measurements within a measuring range of 0 to 500 µm is available. Capable of the most precise measurements of non-ferromagnetic coatings, it is especially accurate within the lower measuring range.

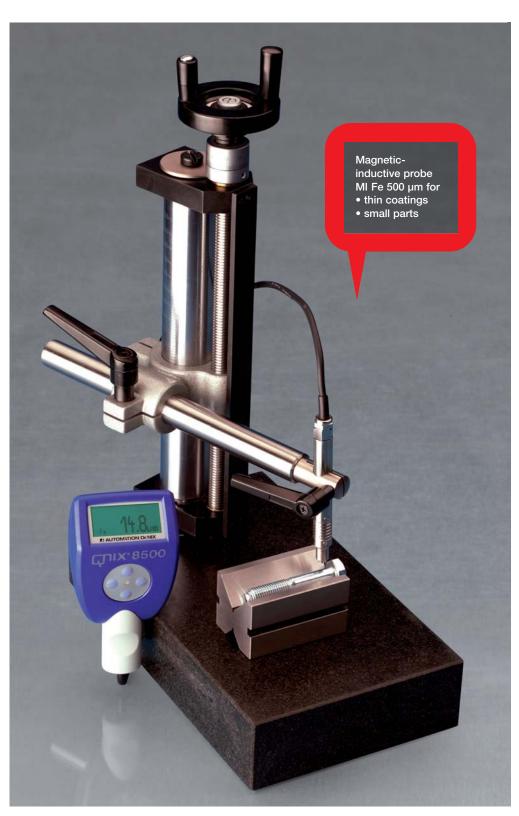
Designed to measure thin non-ferromagnetic metal coatings (such as: chromium, copper, zinc, etc) as well as lacquer, enamel or plastic coatings on steel substrates using the magneticinductive measuring method. Our probes provide measurements in accordance with the DIN EN ISO 2178, ISO 2808 and ASTM B499 standards.

Measure manually or use a measuring stand

Thanks to our pen shape probe manual adjustments on measuring objects are easy to achieve and accurate. For applications demanding highest precision, we recommend mounting the probe on a measuring stand, available with additional sample holders.

Broad range of applications

Our new probe – the latest modular addition to the QNix® 8500 measurement system – allows for individual customization to conveniently measure thin coatings on small parts.







Examples of use

- Measurements on angle brackets, fasteners, shim washers, screws, bolts and nuts.
- Ensuring within a measuring range of 20 µm - the reliability of protective coatings on steel bolts and nuts used for e.g. rotor mounts of wind energy plants, fasteners on bridge or window fixings.
- Used for hard thin film coatings (Physical Vapour Deposition - PVD-coatings), such as: TiN, TiCrN, CrN and TiAIN

Product advantages

- Designed for manual measurements and the use of stand equipment
- Proven easy-to-use guided operation of the QNix® 8500 measurement system
- Magnetic-inductive and (optional) Hall-effect measurement methods can be combined in one gauge
- Interchangeable probes
- Individual naming of calibration programs and memory
- Excellent probe adjustment thanks to the pen shape
- Rugged probe with stainless steel housing
- Digital measurement electronics linked with measuring probe for keeping the zero ballance while interchanging probes

Available application-software

Now, user-oriented PC software complements the QNix® 8500 measurement system, adding a variety of options for real-life data analysis and gauge configuration:

- Wireless communication between PC and gauge
- Gauge memory read-out
- Flexible data evaluation with Microsoft Excel
- Gauge configuration using the PC
- Supports all common languages
- Online measurements

Scope of Supply

- Measuring probe MI Fe 500 µm
- Carrying-case (probe case only or together with the QNix® 8500 carrying-case)
- 2 alignment rings
- Steel reference plate, circular, 25 mm in diameter
- Reference foils: ca. 6, 11, 24, 50 µm
- Certificate
- Instruction manual

Optional

- Measurement stand
- Sample holder

Technical Data QNix® 8500 Magnetic-Inductive Measurement Probe MI Fe 500 μm

Measuring Principle	Magnetic Measuring Method Fe: magnetic-principle ref *Fe
Standards & Regulation	DIN EN ISO 2808, DIN 50981, ISO 2178, BS 5411 (11), BS 3900 - C5, ASTM B499, ASTM D 1186, ASTM D 7091
Probe Type	QNix® 8500 probe type
Measurement Range	Fe: 0.0 to 500 µm or approx. Fe: 0.0 to 20 mil
Metric System µm/mil	with the QNix® 8500 gauge
Measuring Interval	1600 ms
Repeatability regarding the Automation-Standards	\pm (0.1 μm + 0.8% of the measurement value)
Trueness regarding the Automation-Standards after Calibration	\pm (0.3 μm + 2% of the measurement value) after calibration
Minimum Measuring Area	Diameter: 7.0 mm Measuring radius: 3.5 mm (*1)
Minimum Curvature	smallest convex radius : 4 mm (*1) smallest concave radius: 5 mm (*2)
Minimum Thickness of Base Material	Fe: 0,4 mm (*1)
Operating Temperature	0° C to 50° C (32° F to 122° F)
Storage Temperature	-10° C to 60° C (14° F to 140° F)
Power Supply	From gauge
Dimensions (L x W x H in mm)	Probe without extension cable 120 mm x 12 mm x 12 mm (4.72" x 0.47" x 0.47")
Weight	approx. 95 g

- Measuring of non-ferromagnetic coatings on ferromagnetic substrate, e.g. measuring on steel- or iron substrates
- in regard to a maximum deviation of 10 % of the measurement value at coating thicknesses higher than 1 % of the measuring range. Measurements on smallest geometrical forms are possible with specific one-point or two-point calibrations.
- in regard to the measuring probes geometry

Technical data subject to change without notice









Robert-Perthel-Strasse 2 · 50739 Cologne Phone +49 (0) 221-917455-0 Fax +49 (0) 221-171221 email info@qnix.de www.qnix.de